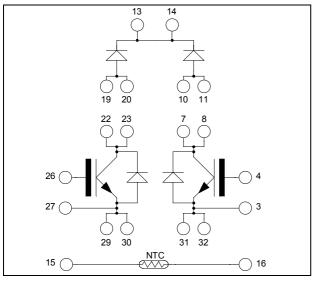
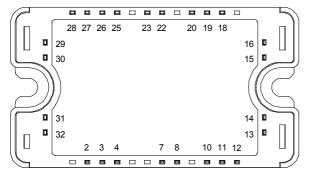


Dual Boost Chopper NPT IGBT Power Module

$V_{CES} = 600V$ $I_{C} = 50A$ (a) $T_{C} = 80^{\circ}C$





All multiple inputs and outputs must be shorted together Example: 13/14 ; 29/30 ; 22/23 ...

Absolute maximum ratings

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction (PFC)
- Interleaved PFC

Features

- Non Punch Through (NPT) Fast IGBT .
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 100 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
 - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
 - High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation •
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a single boost of twice the current capability
- **RoHS** compliant

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		600	V
I _C	Continuous Collector Current	$T_C = 25^{\circ}C$	65	
		$T_C = 80^{\circ}C$	50	Α
I _{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	230	
V _{GE}	Gate – Emitter Voltage		±20	V
P _D	Maximum Power Dissipation	$T_C = 25^{\circ}C$	250	W
RBSOA	Reverse Bias Safe Operating Area	$T_{j} = 125^{\circ}C$	100A @ 500V	

🗱 🕬 TION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



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All ratings (a) $T_i = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics Symbol **Characteristic Test Conditions** Тур Max Unit Min $V_{GE} = 0\overline{V}$ $T_i = 25^{\circ}C$ 250 Zero Gate Voltage Collector Current μA ICES $V_{CE} = 600 V$ $T_i = 125^{\circ}C$ 500 $T_i = 25^{\circ}C$ $V_{GE} = 15V$ 1.7 2.0 2.45 V Collector Emitter Saturation Voltage V_{CE(sat)} $T_i = 125^{\circ}C$ $I_C = 50A$ 2.2 $V_{GE} = V_{CE}, I_C = 1 \text{mA}$ Gate Threshold Voltage V_{GE(th)} 4 V 6 $V_{GE} = 20V, V_{CE} = 0V$ 400 IGES Gate – Emitter Leakage Current nA **Dynamic Characteristics** Symbol **Characteristic Test Conditions** Min Typ Max Unit 2200 Cies Input Capacitance $V_{GE} = 0V$ $V_{CE} = 25V$ pF 323 **Output Capacitance** Coes f = 1MHzReverse Transfer Capacitance 200 Cres Total gate Charge $V_{GE} = 15V$ 166 Q_g $V_{Bus} = 300V$ 20 nC Q_{ge} Gate - Emitter Charge $I_C = 50A$ Gate - Collector Charge 100 Qgc T_{d(on)} Turn-on Delay Time Inductive Switching (25°C) 40 $V_{GE} = 15V$ Rise Time 9 Tr $V_{Bus} = 400V$ ns Turn-off Delay Time 120 T_{d(off)} $I_C = 50A$ $R_G = 2.7\Omega$ $T_{\rm f}$ Fall Time 12 Inductive Switching (125°C) 42 T_{d(on)} Turn-on Delay Time $V_{GE} = 15V$ T_r Rise Time 10 $V_{Bus} = 400V$ ns T_{d(off)} Turn-off Delay Time 130 $I_C = 50A$ 21 T_{f} Fall Time $R_G = 2.7\Omega$ $V_{GE} = 15\overline{V}$ E_{on} Turn-on Switching Energy $T_i = 125^{\circ}C$ 0.5 $V_{Bus} = 400V$ mJ $I_C = 50A$ $T_i = 125^{\circ}C$ Eoff Turn-off Switching Energy 1 $R_G = 2.7\Omega$ $V_{GE} \le 15V$; $V_{Bus} = 360V$ 225 I_{sc} Short Circuit data А $t_p \le 10 \mu s$; $T_i = 125^{\circ}C$

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit		
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V	
I _{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_j = 25^{\circ}C$		250			
	Waximum Reverse Leakage Current	v _R =000 v	$T_{j} = 125^{\circ}C$			500	μA	
$I_{\rm F}$	DC Forward Current		$Tc = 70^{\circ}C$		60		А	
$V_{\rm F}$	Diode Forward Voltage	$I_F = 60A$			1.6	1.8	V	
		$I_{\rm F} = 120 {\rm A}$		1.9				
		$I_F = 60A$	$T_{j} = 125^{\circ}C$		1.4			
t _{rr}	Reverse Recovery Time	I COL	$T_j = 25^{\circ}C$		130		ns	
۲r	Reverse Recovery Time	$I_{\rm F} = 60 \text{A}$ $V_{\rm F} = 400 \text{V}$	$I_F = 60A$ $V_R = 400V$	$T_j = 125^{\circ}C$		170		115
Q _{rr}	Reverse Recovery Charge	$di/dt = 200 \text{ A}/\mu \text{s}$	$T_j = 25^{\circ}C$		220		nC	
	Reverse Receivery charge		$T_{j} = 125^{\circ}C$		920		nc	

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Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

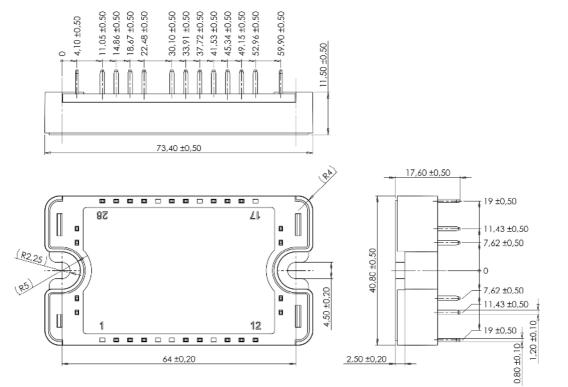
Symbol	Characteristic		Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100^{\circ}C$		4		%
	D					

 $= \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$ T: Thermistor temperature R_T: Thermistor value at T

Thermal and package characteristics

Symbol	Characteristic				Min	Тур	Max	Unit	
R _{thJC}	Junction to Case Thermal Resistance		IGB	Т			0.5	°C/W	
	R _{th} JC	sunction to case Therman Resistance		Chopper Diode				0.9	C/ w
VISOL	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V		
T _J	Operating junction temperature range			-40		150			
T _{STG}	Storage Temperature Range			-40		125	°C		
T _C	Operating Case Temperature				-40		100		
Torque	Mounting torque	To heatsink	τ	M4	2		3	N.m	
Wt	Package Weight						110	g	

SP3 Package outline (dimensions in mm)

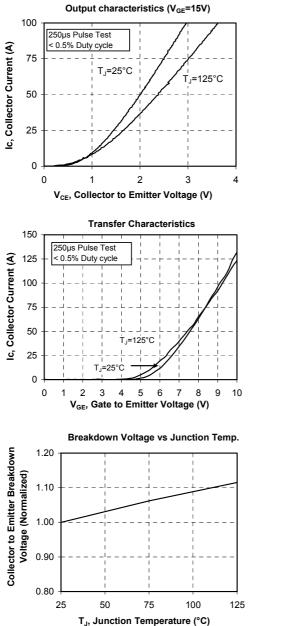


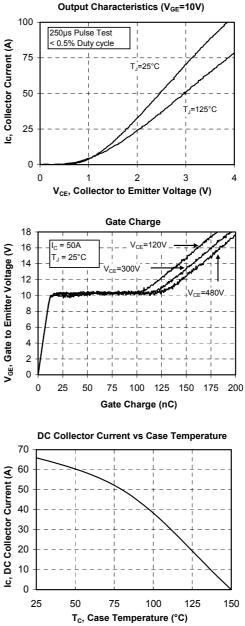
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

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Typical IGBT Performance Curve

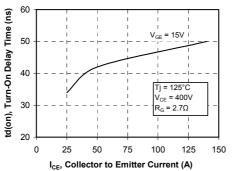


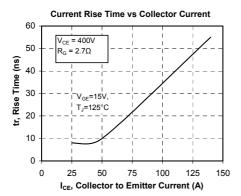


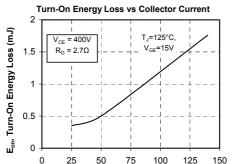




Turn-On Delay Time vs Collector Current

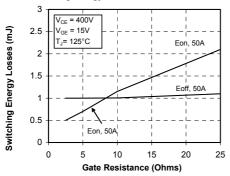




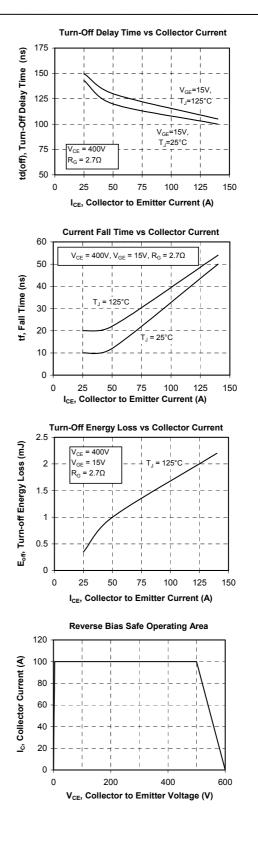


Switching Energy Losses vs Gate Resistance

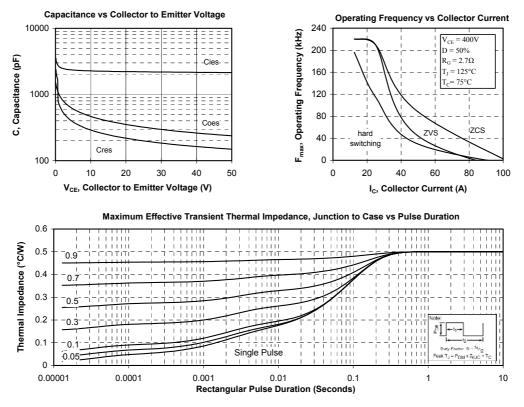
I_{CE}, Collector to Emitter Current (A)



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